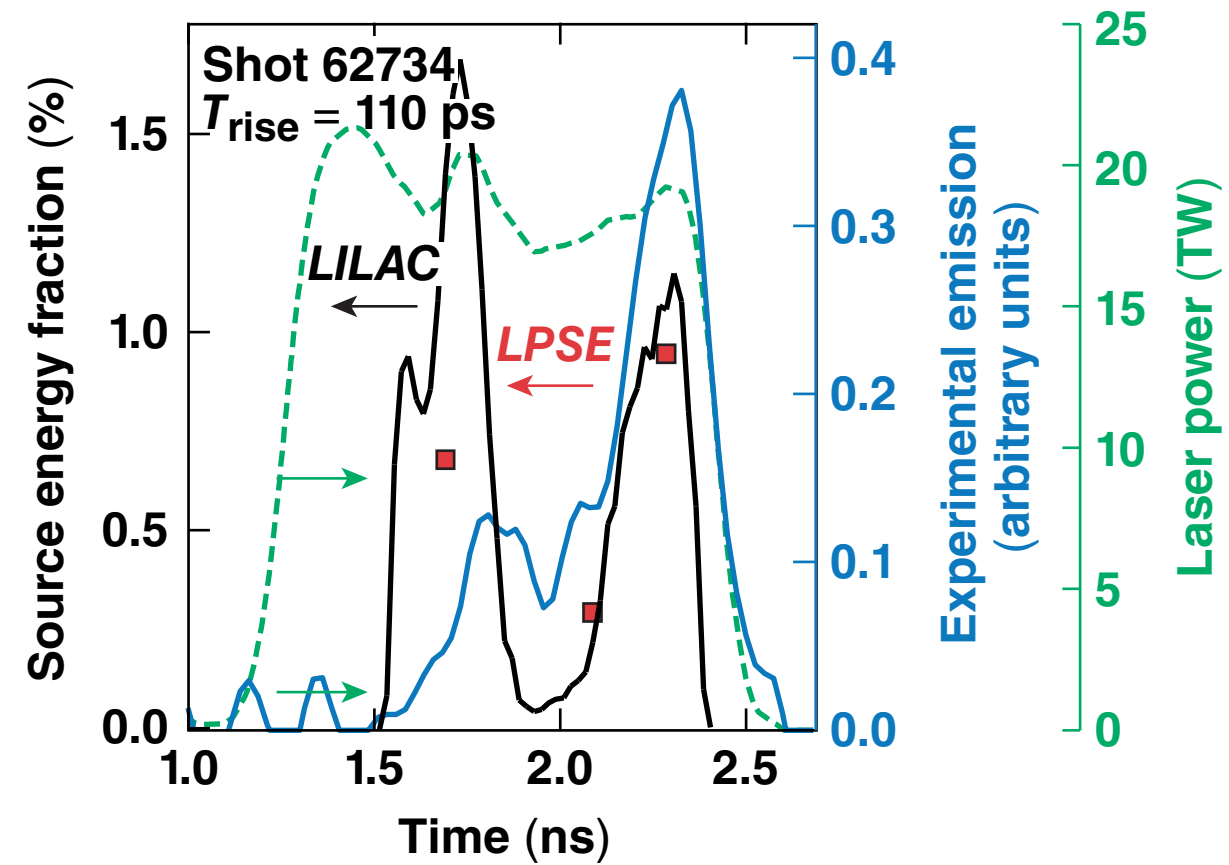
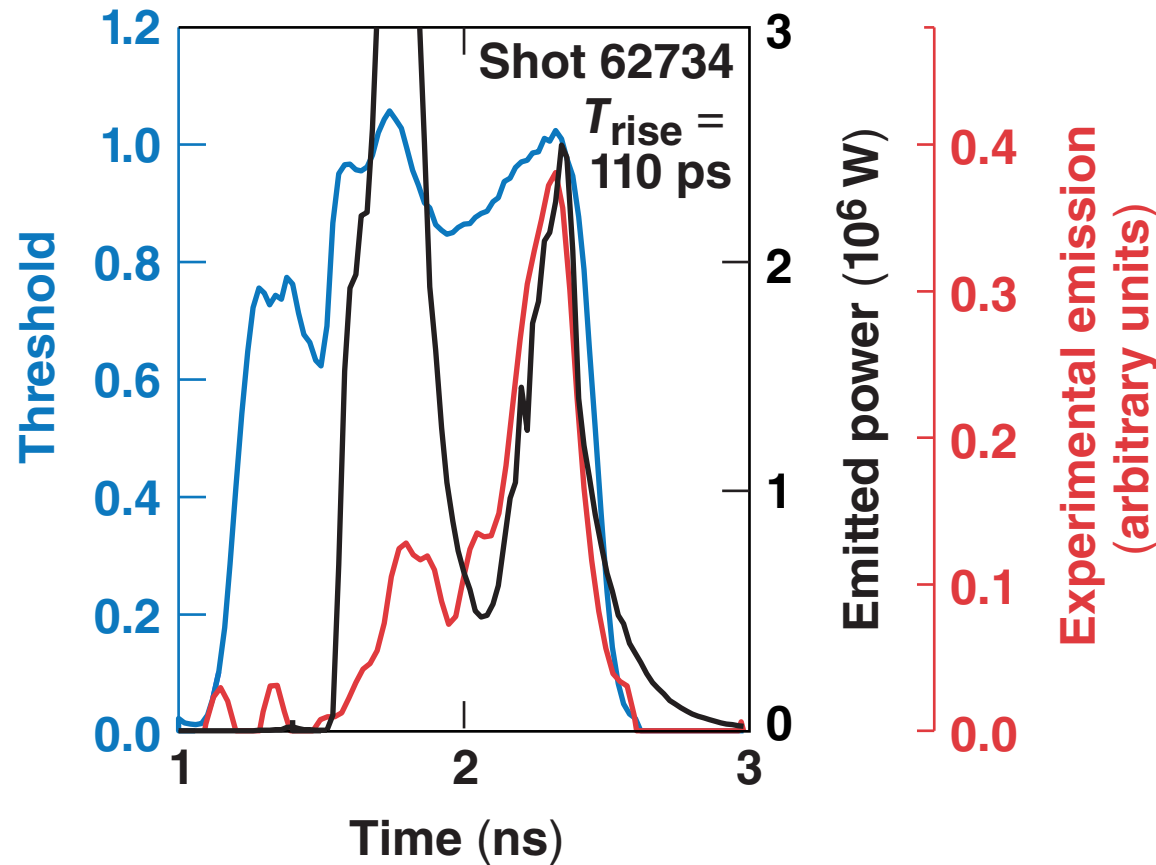


Understanding Hard X-Ray Emission in Direct-Drive Implosions



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Summary

The fast-electron production from two-plasmon decay (TPD) depends on the gain and on the thermal electron distribution above 10 keV



- Simulations of hard x-ray (HXR) emission from TPD electrons in the hydrocode *LILAC* and in *LPSE** show earlier emission than in experiments, which depends on the rise time of the drive pulse
- *LPSE* simulations show that low thermal-electron temperatures can reduce the fast-electron production
- Simulations with the Fokker–Planck–Vlasov code, *FPI*,** confirm that the population of ~10-keV thermal electrons fills up more slowly than the fastest drive-pulse rise times

*J. F. Myatt *et al.*, *Phys. Plasmas* **24**, 056308 (2017).

J. P. Matte *et al.*, *Phys. Rev. Lett.* **53, 1461 (1984).

Collaborators



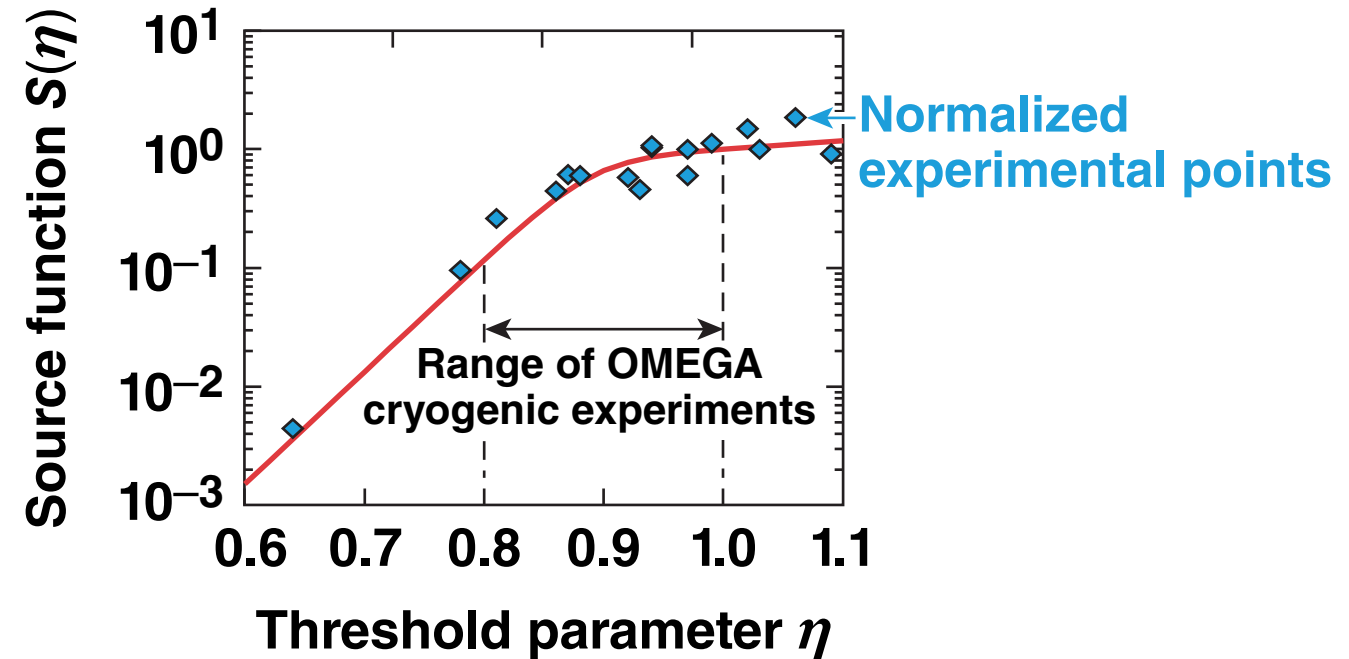
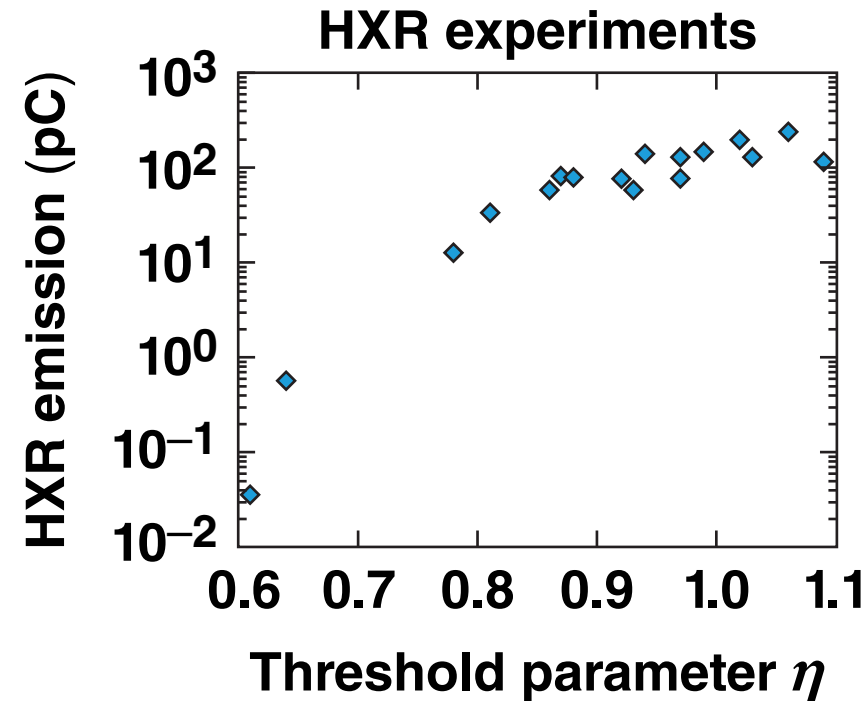
R. K. Follett, C. Stoeckl, and W. Seka

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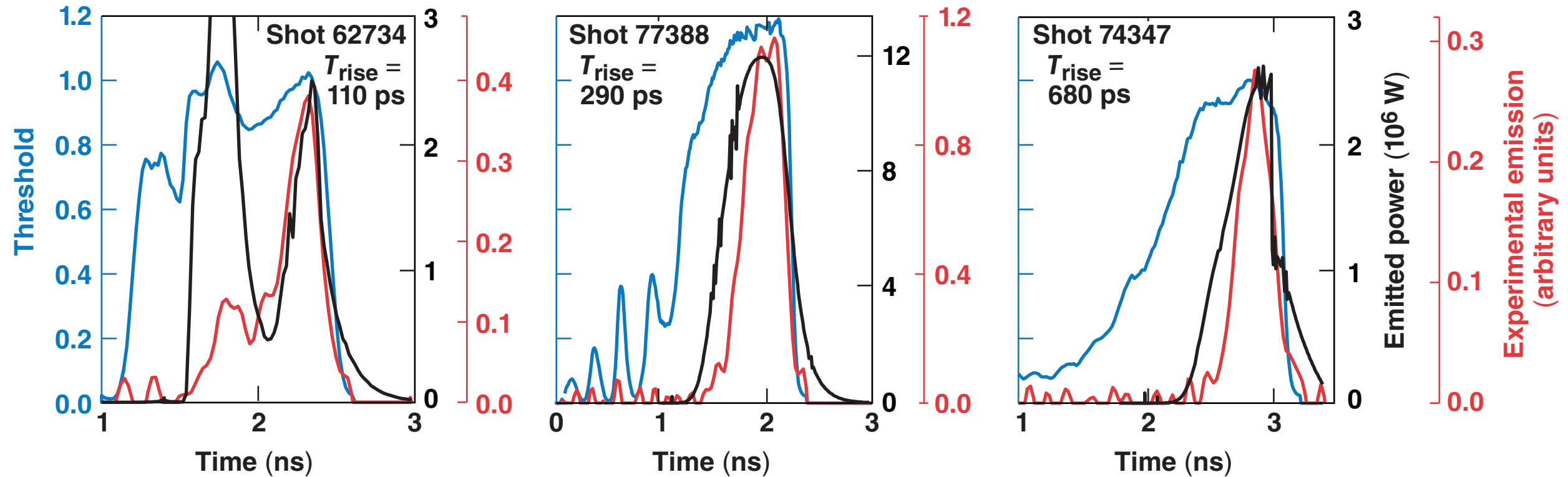
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The source of fast electrons is based on the measured HXR emission from intensity-sweep experiments



- The HXR emission depends on the threshold parameter: $\eta = I_{14} \text{ (at } n_c/4) * L(\mu\text{m}) / [233 * T \text{ (keV)}]^\dagger$
- The source function was designed to follow the same dependence as the HXR emission
- The source energy is given by $E_s = F_s * S(\eta)$, where F_s is adjusted to give the measured HXR total emission energy

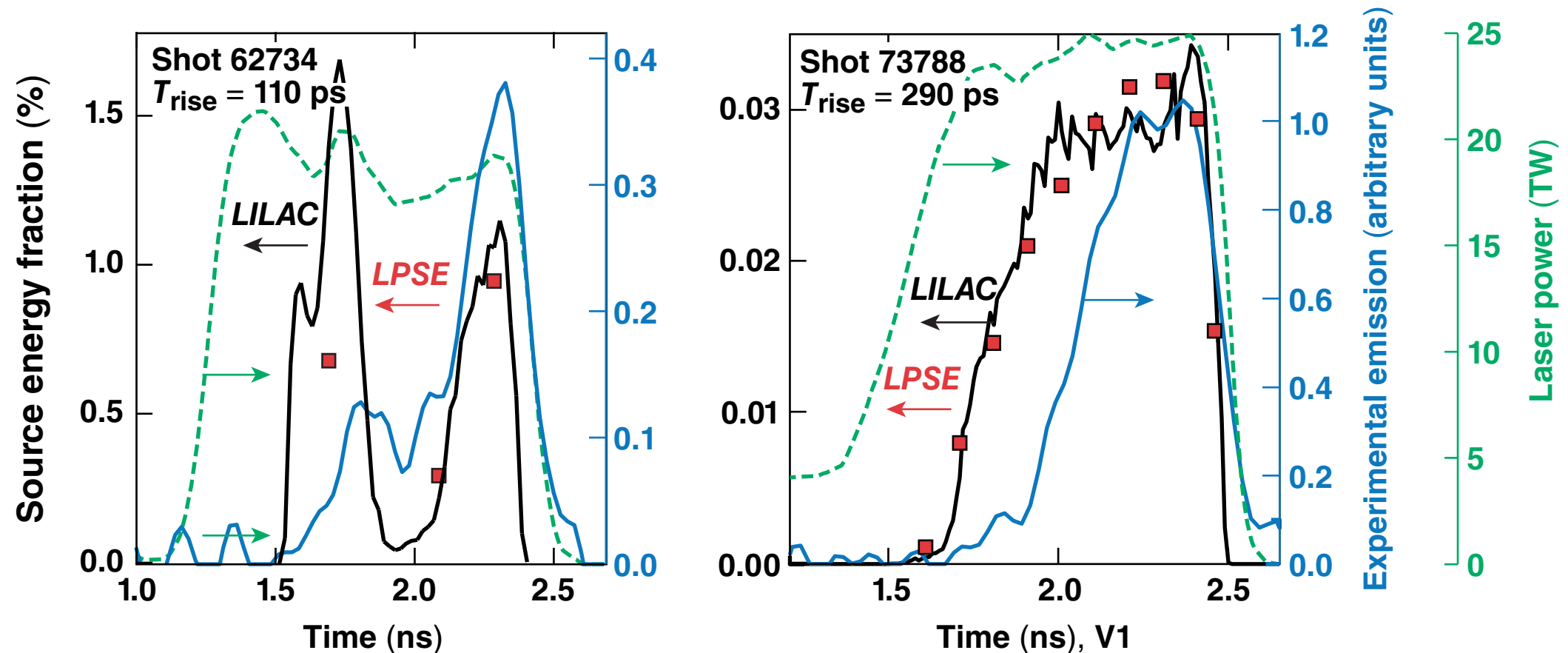
The amount of early computed HXR emission depends on the drive pulse rise time



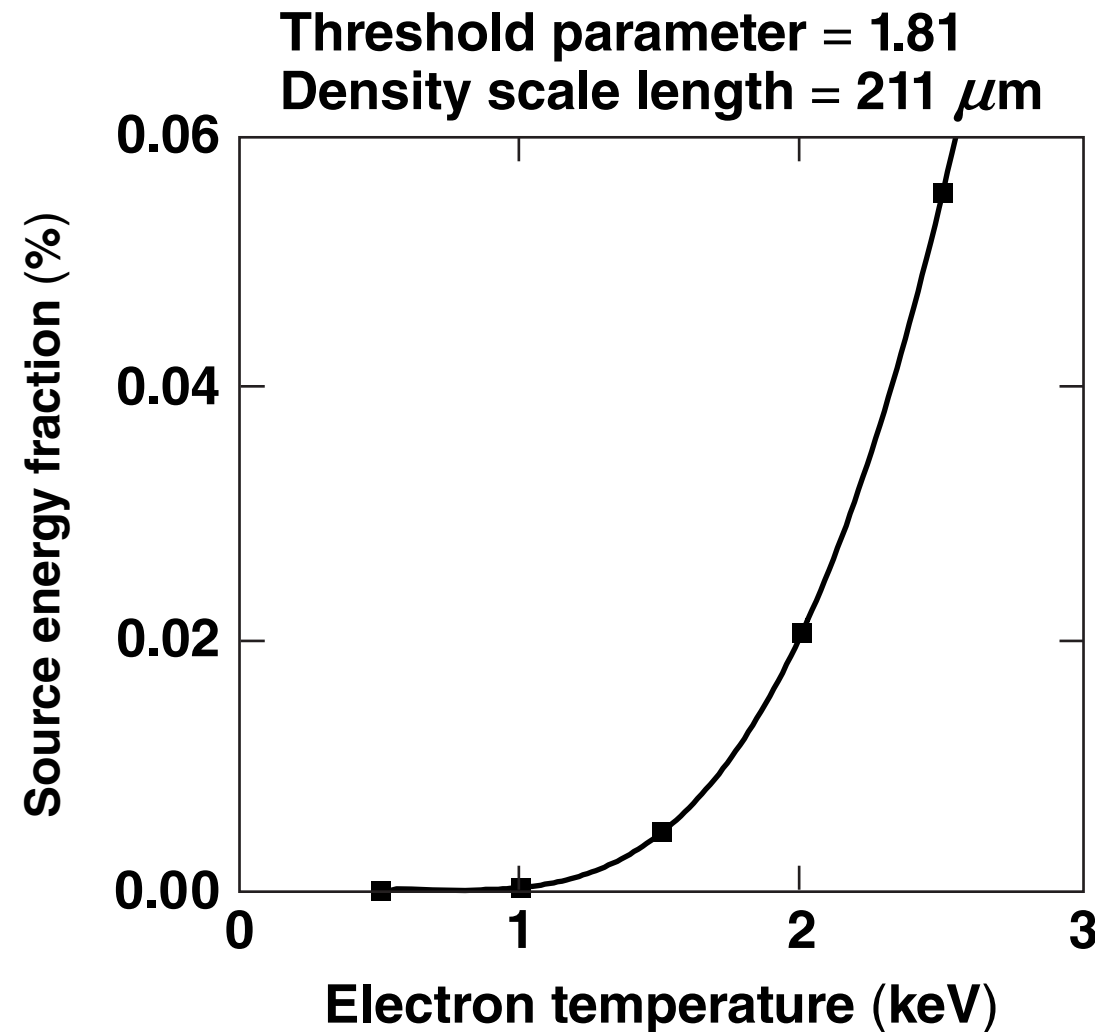
- The differences in early measured emission could come from hydrodynamic uncertainty (<20% lower threshold parameter)
- That the differences slowly vanish during the drive pulse suggests some time-dependent relaxation effect, such as the Maxwellization of high-energy electrons

The early emission from *LILAC* is supported by *LPSE** simulations for the energy fraction into electrons >50 keV

- *LPSE* (laser-plasma simulation environment) is a 3-D laser-plasma interaction code
- The *LPSE* simulations were carried out with a Maxwellian thermal-electron distribution function



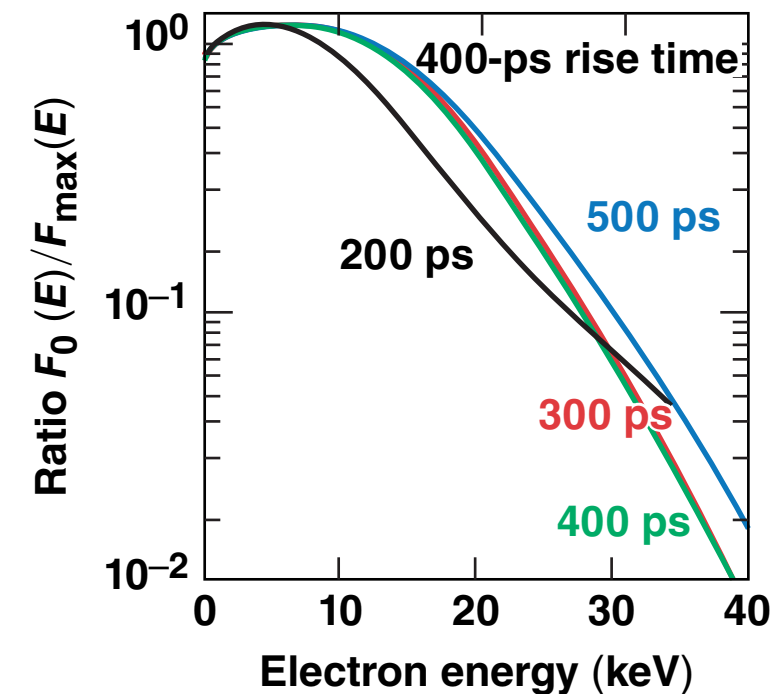
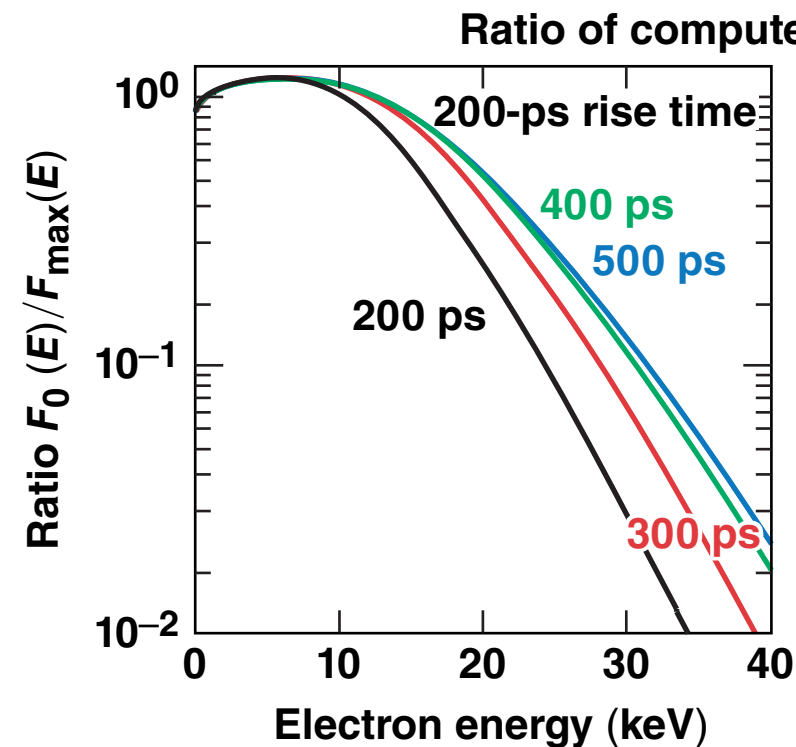
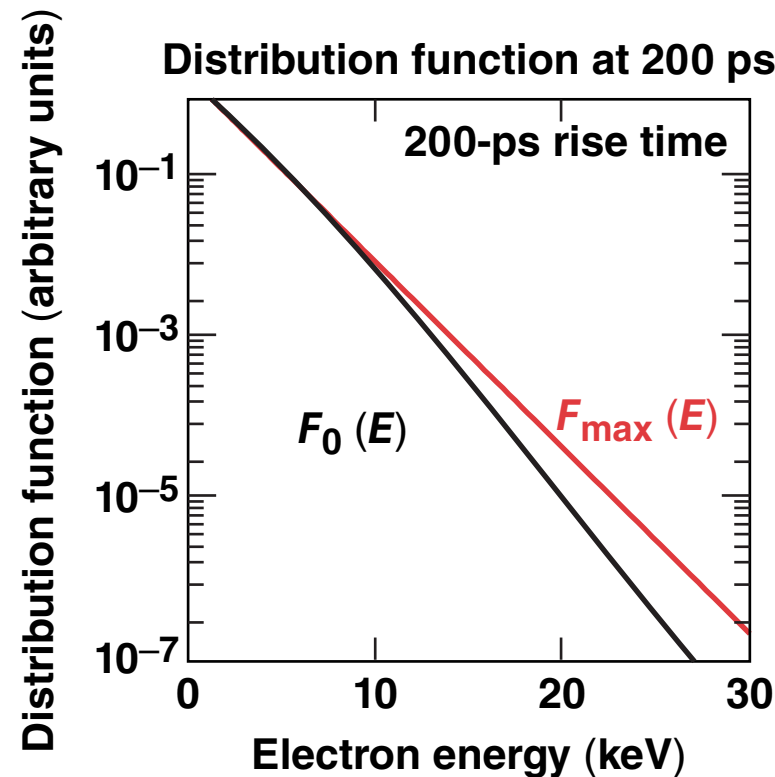
Simulations with *LPSE** imply that electrons with energy >10 keV are needed to generate TPD fast electrons



- *LPSE* simulations were carried out with a Maxwellian distribution
 - The threshold parameter
 - $\eta = I_{14} \text{ (at } n_c/4) * L(\mu\text{m}) / [233 * T \text{ (keV)}]$
- is kept constant by varying the laser intensity from 1×10^{14} to 5×10^{14} W/cm²

FPI* simulations show that, for the fast-rising pulse, the distribution function needs 400 ps to equilibrate

- FPI is a Fokker–Planck code that simulates laser absorption and nonlocal thermal electron transport
- The simulations used linearly rising laser pulses of 200 ps and 400 ps followed by a constant pulse at the peak intensity of $9 \times 10^{14} \text{ W/cm}^2$



The decrease in the electron population >10 keV may not be the only cause for the lack of early emission in the fast-rising pulse cases.

The fast-electron production from two-plasmon decay (TPD) depends on the gain and on the thermal electron distribution above 10 keV

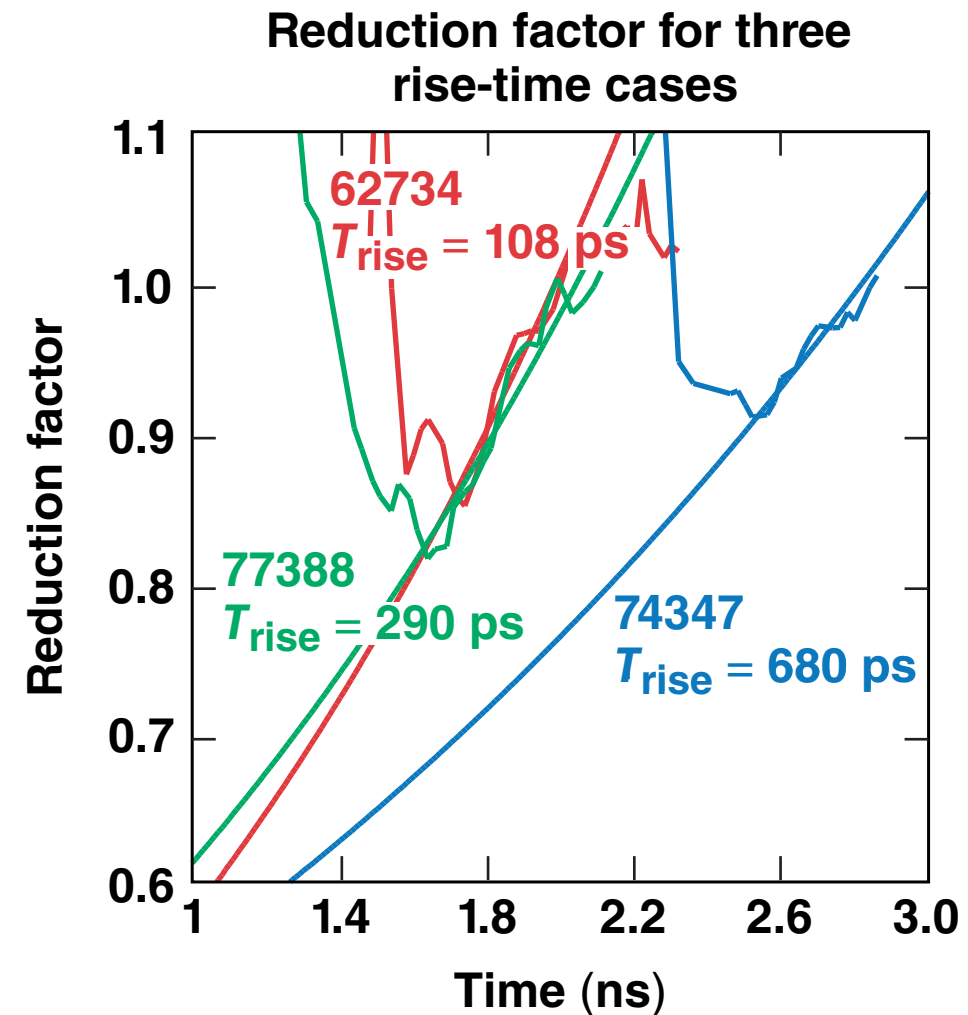
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A threshold reduction factor was obtained from the ratio of the measured to the computed HXR emissions

- This factor is obtained such that the value of the computed threshold parameter gives the same HXR emission level as that measured
- The correction factor can be expressed as an exponential in time

$$R_F = \exp[t/2 \times 10^{-9} - 1.0]$$

- The exponential fit is done from the start of the HXR emission to the peak



Applying the reduction factor resulted in closer agreement between simulated and measured HXR emission

